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## **Information technology — Radio frequency identification device performance test methods —**

### **Part 3: Test methods for tag performance**

*Technologies de l'information — Méthodes d'essai des performances du dispositif d'identification par radiofréquence —*

*Partie 3: Méthodes d'essai des performances du tag*

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## Contents

	Page
<b>Foreword .....</b>	<b>v</b>
<b>Introduction.....</b>	<b>vi</b>
<b>1 Scope.....</b>	<b>1</b>
<b>2 Normative references.....</b>	<b>1</b>
<b>3 Terms and definitions .....</b>	<b>2</b>
<b>4 Symbols and abbreviated terms .....</b>	<b>2</b>
<b>5 Conditions applicable to the test methods.....</b>	<b>2</b>
<b>5.1 Number of tags to be tested.....</b>	<b>2</b>
<b>5.2 Test environment.....</b>	<b>3</b>
<b>5.3 RF environment .....</b>	<b>3</b>
<b>5.4 Pre-conditioning .....</b>	<b>3</b>
<b>5.5 Default tolerance .....</b>	<b>3</b>
<b>5.6 Total measurement uncertainty .....</b>	<b>3</b>
<b>5.7 Test result reporting.....</b>	<b>3</b>
<b>5.8 Test mounting material .....</b>	<b>3</b>
<b>5.9 Test communication parameters .....</b>	<b>3</b>
<b>5.10 Test equipment limits.....</b>	<b>4</b>
<b>5.11 Human exposure to EMF .....</b>	<b>4</b>
<b>6 Setup of test equipment for tag test.....</b>	<b>4</b>
<b>6.1 Test apparatus and test circuits for ISO/IEC 18000-2 tags .....</b>	<b>4</b>
<b>6.2 Test apparatus and test circuits for ISO/IEC 18000-3 tags .....</b>	<b>4</b>
<b>6.3 Test apparatus and test circuits for ISO/IEC 18000-6 tags .....</b>	<b>4</b>
<b>6.4 Test apparatus and test circuits for ISO/IEC 18000-7 tags .....</b>	<b>5</b>
<b>7 Functional tests for inductive tags as defined in ISO/IEC 18000-2 and ISO/IEC 18000-3 and ISO/IEC 18000-6 .....</b>	<b>6</b>
<b>7.1 Identification magnetic field threshold (<math>H_{THR}</math> Identification).....</b>	<b>6</b>
<b>7.2 Reading magnetic field threshold (<math>H_{THR}</math> Read).....</b>	<b>8</b>
<b>7.3 Writing magnetic field threshold (<math>H_{THR}</math> Write).....</b>	<b>10</b>
<b>7.4 Maximum operating magnetic field (<math>H_{max}</math>) .....</b>	<b>12</b>
<b>7.5 Survival magnetic field (<math>H_{Survival}</math>) .....</b>	<b>13</b>
<b>7.6 Load modulation (<math>L_m</math>).....</b>	<b>14</b>
<b>8 Functional tests for propagative tags as defined in ISO/IEC 18000-6 .....</b>	<b>17</b>
<b>8.1 Identification electromagnetic field threshold (<math>E_{THR}</math> Identification) and frequency peak(s).....</b>	<b>17</b>
<b>8.2 Reading electromagnetic field threshold (<math>E_{THR}</math> Read) .....</b>	<b>18</b>
<b>8.3 Writing electromagnetic field threshold (<math>E_{THR}</math> Write) .....</b>	<b>20</b>
<b>8.4 Sensitivity degradation (<math>S_{Degradation}</math>) .....</b>	<b>21</b>
<b>8.5 Maximum operating electromagnetic field (<math>E_{max}</math>) .....</b>	<b>23</b>
<b>8.6 Survival electromagnetic field (<math>E_{Survival}</math>) .....</b>	<b>24</b>
<b>8.7 Delta radar cross section (<math>\Delta RCS</math>).....</b>	<b>26</b>
<b>8.8 Interference rejection (<math>I_{Rejection}</math>) .....</b>	<b>27</b>
<b>8.9 Maximum identification fade rate (<math>E_{Fade}</math> Identification) .....</b>	<b>29</b>
<b>8.10 Maximum write fade rate (<math>E_{Fade}</math> Write).....</b>	<b>30</b>
<b>9 Functional tests for 433,920 MHz propagative tags as defined in ISO/IEC 18000-7 .....</b>	<b>31</b>
<b>9.1 Identification electromagnetic field threshold (<math>E_{THR}</math> Identification) and frequency tolerance.....</b>	<b>31</b>
<b>9.2 Reading electromagnetic field threshold (<math>E_{THR}</math> Read) and frequency tolerance .....</b>	<b>33</b>
<b>9.3 Writing electromagnetic field threshold (<math>E_{THR}</math> Write) .....</b>	<b>35</b>
<b>9.4 Sensitivity Directivity (<math>S_{Directivity}</math>) .....</b>	<b>36</b>

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9.5	Interference rejection ( $I_{\text{Rejection}}$ ) .....	39
9.6	Maximum operating electromagnetic field ( $E_{\max}$ ) .....	42
9.7	Survival electromagnetic field ( $E_{\text{Survival}}$ ).....	43
Annex A (informative) Resonant frequency and Q factor measurement for inductive tag .....		46
Annex B (normative) Test apparatus modification for ISO/IEC 18000-3 compliant tags for field strengths > 5 A/m.....		49
Annex C (normative) Test apparatus modification for ISO/IEC 18000-6 compliant tags.....		50
Annex D (informative) Inventory command for all parts of ISO/IEC 18000 .....		52
Bibliography .....		53

This is a preview of "ISO/IEC 18046-3:2012". Click here to purchase the full version from the ANSI store.

## Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

ISO/IEC 18046-3 was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 31, *Automatic identification and data capture techniques*.

This second edition cancels and replaces the first edition (ISO/IEC 18046-3:2007) which has been technically revised.

ISO/IEC 18046 consists of the following parts, under the general title *Information technology — Radio frequency identification device performance test methods*:

- *Part 1: Test methods for system performance*
- *Part 2: Test methods for interrogator performance*
- *Part 3: Test methods for tag performance*

## Introduction

RFID technology has broad applicability to the Automatic Identification and Data Capture (AIDC) industry in item management. As a wireless communication technique based on Radio Frequency technology the applications cover multiple levels of the industrial, commercial and retail supply chains. These may include:

- Freight containers
- Returnable Transport Items (RTI)
- Transport units
- Product packaging
- Product tagging

Performance tests define test methods that deliver results that allow the comparison of different RFID systems, interrogator and tags in order to select among them for use in a particular application.

The performance characteristics of devices (tags and interrogation equipment) may vary drastically due to application factors as well as the particular RFID air interface (frequency, modulation, protocol, etc.) being supported. Of key concern is the matching of the various performance characteristics to the user application. Additionally, in an open environment users of such technology demand multiple sources for these devices from technology providers. A key challenge is a method of evaluating the differences between various technology providers' products in a consistent and equitable manner.

This International Standard provides a framework for meeting the above noted concern and challenges. To this end, clear definitions of performance as relate to user application of RFID technology in the supply chain are provided. Based on such application-based definitions test methods are defined with attention to the test parameters required for a consistent evaluation of RFID devices.

Of particular significance, these tests are defined for RFID devices having one antenna. It is common practice to have products with both single and multiple antennas to define an RFID transaction zone sufficient for the application. The defined methods can easily be extended from equipment with a single antenna to apply to equipment with multiple antennas, in order to evaluate performance under conditions more closely matching those of a particular application.

The International Organization for Standardization (ISO) and International Electrotechnical Commission (IEC) draw attention to the fact that it is claimed that compliance with this document may involve the use of patents.

The ISO and IEC take no position concerning the evidence, validity and scope of these patent rights.

The holder of this patent right has assured the ISO and IEC that he is prepared to grant a free license to an unrestricted number of applicants on a worldwide, non-discriminatory basis and under other reasonable terms and conditions to make, use, and sell RFID reader antenna design / patterns for implementations of this ISO/IEC International Standard, which is related to testing. In this respect, the statements of the holder of this patent right are registered with the ISO and IEC. Information may be obtained from the following company.

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Contact details	Patent number	Affected subclause(s) in this part of ISO/IEC 18046
Impinj inc 701 N. 34 <sup>th</sup> Street, Suite 300 Seattle, WA 98103 Tel: 206/517-5300 Fax: 206/517-5262	Patent pending	6.3.2, 7.1.2.3, 7.3.2.3, 7.4.2.1, 7.5.2.1, 7.6.2.3

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights other than those identified above. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

The latest information on IP that may be applicable to this part of ISO/IEC 18046 can be found at [www.iso.org/patents](http://www.iso.org/patents).